

Application/Control I	No. Applicant(s)/Patent u Reexamination	ınder
10/689,714	CHEN, HSIN WAN	G _
Examiner	Art Unit	
David T Fidai	2729	

	SEARCHED		
Class	Subclass	Date	Examiner
206	37 38 39 39.5 232 449 555 804	9/13/2005	DTF
206	815	9/13/2005	DTF
220	345.2	9/13/2005	DTF
220	345.3	9/13/2005	DTF
312	330.1 333	9/13/2005	DTF
312	348.1	9/13/2005	DTF
312	348.4	9/13/2005	DTF
312	234.3	9/13/2005	DTF
221 -	232 268 279	9/13/2005	DTF
221	255	9/13/2005	DTF
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	search - see ce priintout	9/14/2005	DTF

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
BRS text search Inventor Name search Consulted following Examiners; Robin Hylton - class 220 James Hansen - class 312	9/13/2005	DTF